

<b>Notice of References Cited</b>	Application/Control No. 10/577,170		Applicant(s)/Patent Under Reexamination KIM, YOUNG-WOO	
	Examiner John P. Leubecker		Art Unit 3739	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,166,787 A	11-1992	Irion, Klaus	348/75
*	B	US-5,305,121 A	04-1994	Moll, Frederic H.	348/45
*	C	US-5,368,015 A	11-1994	Wilk, Peter J.	600/104
*	D	US-5,494,483 A	02-1996	Adair, Edwin L.	600/111
*	E	US-6,066,090 A	05-2000	Yoon, InBae	600/113
*	F	US-6,450,950 B2	09-2002	Irion, Klaus	600/170
*	G	US-6,976,956 B2	12-2005	Takahashi et al.	600/166
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.